Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/615,475	DUPAQUIS ET AL.
Examiner	Art Unit
Tan V. Mai	2193

SEARCHED					
Class	Subclass	Date	Examiner		
708	620, 625	6/27/2006	MAI		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	6/27/2006	MAI
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